Notice of References Cited Application/Control No. 10/585,225 Examiner AKLIL TESFAYE Applicant(s)/Patent Under Reexamination WONG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2006/0195866	08-2006	Thukral, Vivek 725/034	
*	В	US-2002/0100042	07-2002	Khoo et al.	725/34
*	С	US-2002/0083444	06-2002	Blasko et al.	725/35
*	D	US-2003/0229893	12-2003	Sgaraglino, Vito	725/37
*	Е	US-2002/0078441	06-2002	Drake et al.	725/9
	F	US-			
	G	US-			
	Ξ	US-		7 = 17	
	ı	US-			
	J	US-			
	K	US-			
	Ĺ	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
6	R					
	s					
					100	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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